

Notice of References Cited	Application/Control No. 10/629,634	Applicant(s)/Patent Under Reexamination IWAI ET AL.	
	Examiner TUAN A. PHAM	Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,921,170	07-2005	Nevermann, Peter	353/28
	B	US-			
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	J	US-			
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	L	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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